

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/552,335	LEE, SANG-YUP	
Examiner		Art Unit		Page 1 of 1
Nathan E. Durham		3765		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,273,302 A	02-1942	HIRSCH VINEBERG JOSEPH	206/280
*	B	US-2,280,138 A	04-1942	HIRSCH VINEBERG JOSEPH	206/284
*	C	US-2,508,579 A	05-1950	MCFALL WILLIAM W	206/284
*	D	US-3,459,348 A	08-1969	MASSON HENRI	223/87
*	E	US-3,758,019 A	09-1973	Strublè, Glenn E.	206/278
*	F	US-4,590,610 A	05-1986	Rhyne, Steven B.	383/23
*	G	US-6,279,791 B1	08-2001	Betman et al.	223/37
*	H	US-6,508,357 B1	01-2003	Faircloth et al.	206/284
*	I	US-2,620,101	12-1952	SALVATORE D AIRO	223/88
*	J	US-2,451,788	10-1948	WAHL ALBERT G	223/88
*	K	US-2,619,269	11-1952	CROSSLAND ARELOUS T	223/89
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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